

# HAF2002

## Silicon N Channel MOS FET Series Power Switching

# HITACHI

ADE-208-503 A (Z)  
2nd. Edition  
October 1997

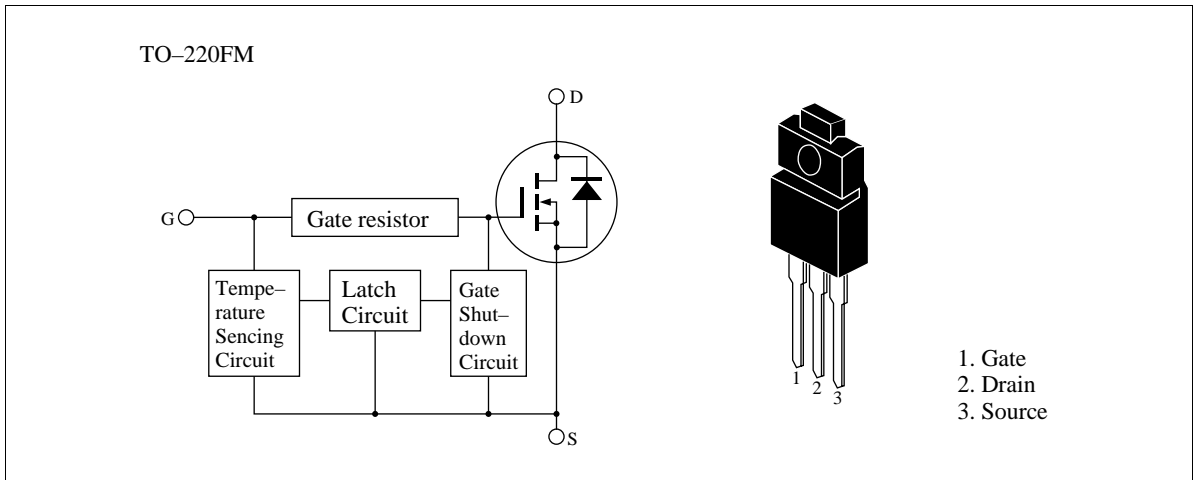
### Features

This FET has the over temperature shut-down capability sensing to the junction temperature.

This FET has the built-in over temperature shut-down circuit in the gate area. And this circuit operation to shut-down the gate voltage in case of high junction temperature like applying over power consumption, over current etc.

- Logic level operation (4 to 6 V Gate drive)
- High endurance capability against to the short circuit
- Built-in the over temperature shut-down circuit
- Latch type shut-down operation (Need 0 voltage recovery)

### Outline



**Absolute Maximum Ratings** ( $T_a = 25^\circ\text{C}$ )

| Item                                   | Symbol                          | Ratings     | Unit             |
|--|---------------------------------|-------------|------------------|
| Drain to source voltage                | $V_{DSS}$                       | 60          | V                |
| Gate to source voltage                 | $V_{GSS}$                       | 16          | V                |
| Gate to source voltage                 | $V_{GSS}$                       | -2.8        | V                |
| Drain current                          | $I_D$                           | 20          | A                |
| Drain peak current                     | $I_{D(pulse)}$ <sup>Note1</sup> | 40          | A                |
| Body-drain diode reverse drain current | $I_{DR}$                        | 20          | A                |
| Channel dissipation                    | $P_{ch}$ <sup>Note2</sup>       | 30          | W                |
| Channel temperature                    | $T_{ch}$                        | 150         | $^\circ\text{C}$ |
| Storage temperature                    | $T_{stg}$                       | -55 to +150 | $^\circ\text{C}$ |

Note: 1.  $PW \leq 10\mu\text{s}$ , duty cycle  $\leq 1\%$   
 2. Value at  $T_a = 25^\circ\text{C}$

**Typical Operation Characteristics**

| Item                                  | Symbol        | Min | Typ  | Max | Unit             | Test Conditions                 |
|---------------------------------------|---------------|-----|------|-----|------------------|---------------------------------|
| Input voltage                         | $V_{IH}$      | 3.5 | —    | —   | V                |                                 |
|                                       | $V_{IL}$      | —   | —    | 1.2 | V                |                                 |
| Input current<br>(Gate non shut down) | $I_{IH1}$     | —   | —    | 100 | $\mu\text{A}$    | $V_i = 8\text{V}, V_{DS} = 0$   |
|                                       | $I_{IH2}$     | —   | —    | 50  | $\mu\text{A}$    | $V_i = 3.5\text{V}, V_{DS} = 0$ |
|                                       | $I_{IL}$      | —   | —    | 1   | $\mu\text{A}$    | $V_i = 1.2\text{V}, V_{DS} = 0$ |
| Input current<br>(Gate shut down)     | $I_{IH(sd)1}$ | —   | 0.8  | —   | $\text{mA}$      | $V_i = 8\text{V}, V_{DS} = 0$   |
|                                       | $I_{IH(sd)2}$ | —   | 0.35 | —   | $\text{mA}$      | $V_i = 3.5\text{V}, V_{DS} = 0$ |
| Shut down temperature                 | $T_{sd}$      | —   | 175  | —   | $^\circ\text{C}$ | Channel temperature             |
| Gate operation voltage                | $V_{OP}$      | 3.5 | —    | 13  | V                |                                 |

## Electrical Characteristics (Ta = 25°C)

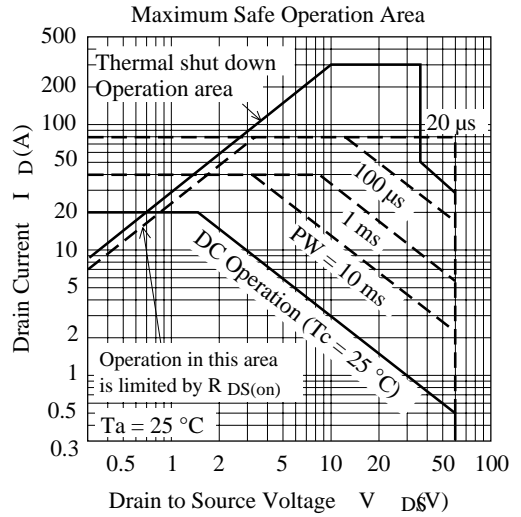
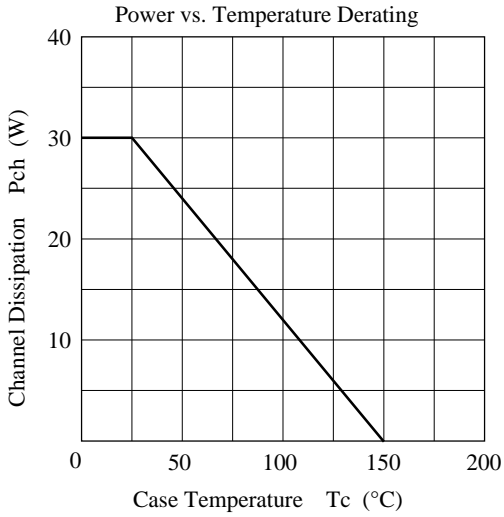
| Item  | Symbol        | Min  | Typ  | Max  | Unit       | Test Conditions                                  |
|---|---------------|------|------|------|------------|--|
| Drain current                                       | $I_{D1}$      | 10   | —    | —    | A          | $V_{GS} = 3.5V, V_{DS} = 2V$                     |
| Drain current                                       | $I_{D2}$      | —    | —    | 10   | mA         | $V_{GS} = 1.2V, V_{DS} = 2V$                     |
| Drain to source breakdown voltage                   | $V_{(BR)DSS}$ | 60   | —    | —    | V          | $I_D = 10mA, V_{GS} = 0$                         |
| Gate to source breakdown voltage                    | $V_{(BR)GSS}$ | 16   | —    | —    | V          | $I_G = 100\mu A, V_{DS} = 0$                     |
| Gate to source breakdown voltage                    | $V_{(BR)GSS}$ | -2.8 | —    | —    | V          | $I_G = -100\mu A, V_{DS} = 0$                    |
| Gate to source leak current                         | $I_{GSS1}$    | —    | —    | 100  | $\mu A$    | $V_{GS} = 8V, V_{DS} = 0$                        |
|   | $I_{GSS2}$    | —    | —    | 50   | $\mu A$    | $V_{GS} = 3.5V, V_{DS} = 0$                      |
|   | $I_{GSS3}$    | —    | —    | 1    | $\mu A$    | $V_{GS} = 1.2V, V_{DS} = 0$                      |
|   | $I_{GSS4}$    | —    | —    | -100 | $\mu A$    | $V_{GS} = -2.4V, V_{DS} = 0$                     |
| Input current (shut down)                           | $I_{GS(op)1}$ | —    | 0.8  | —    | mA         | $V_{GS} = 8V, V_{DS} = 0$                        |
|   | $I_{GS(op)2}$ | —    | 0.35 | —    | mA         | $V_{GS} = 3.5V, V_{DS} = 0$                      |
| Zero gate voltage drain current                     | $I_{DSS}$     | —    | —    | 250  | $\mu A$    | $V_{DS} = 50V, V_{GS} = 0$                       |
| Gate to source cutoff voltage                       | $V_{GS(off)}$ | 1.0  | —    | 2.25 | V          | $I_D = 1mA, V_{DS} = 10V$                        |
| Static drain to source on state resistance          | $R_{DS(on)}$  | —    | 50   | 65   | m $\Omega$ | $I_D = 10A, V_{GS} = 4V$ <sup>Note3</sup>        |
| Static drain to source on state resistance          | $R_{DS(on)}$  | —    | 30   | 43   | m $\Omega$ | $I_D = 10A, V_{GS} = 10V$ <sup>Note3</sup>       |
| Forward transfer admittance                         | $ y_{fs} $    | 6    | 12   | —    | S          | $I_D = 10A, V_{DS} = 10V$ <sup>Note3</sup>       |
| Output capacitance                                  | $C_{oss}$     | —    | 630  | —    | pF         | $V_{DS} = 10V, V_{GS} = 0$<br>$f = 1\text{ MHz}$ |
| Turn-on delay time                                  | $t_{d(on)}$   | —    | 7.5  | —    | $\mu s$    | $I_D = 5A, V_{GS} = 5V$                          |
| Rise time   | $t_r$         | —    | 29   | —    | $\mu s$    | $R_L = 6\Omega$                                  |
| Turn-off delay time                                 | $t_{d(off)}$  | —    | 34   | —    | $\mu s$    |  |
| Fall time   | $t_f$         | —    | 26   | —    | $\mu s$    |  |
| Body-drain diode forward voltage                    | $V_{DF}$      | —    | 1.0  | —    | V          | $I_F = 20A, V_{GS} = 0$                          |
| Body-drain diode reverse recovery time              | $t_{rr}$      | —    | 110  | —    | ns         | $I_F = 20A, V_{GS} = 0$<br>$diF/dt = 50A/\mu s$  |
| Over load shut down operation time <sup>Note4</sup> | $t_{os1}$     | —    | 1.8  | —    | ms         | $V_{GS} = 5V, V_{DD} = 12V$                      |
|   | $t_{os2}$     | —    | 0.7  | —    | ms         | $V_{GS} = 5V, V_{DD} = 24V$                      |

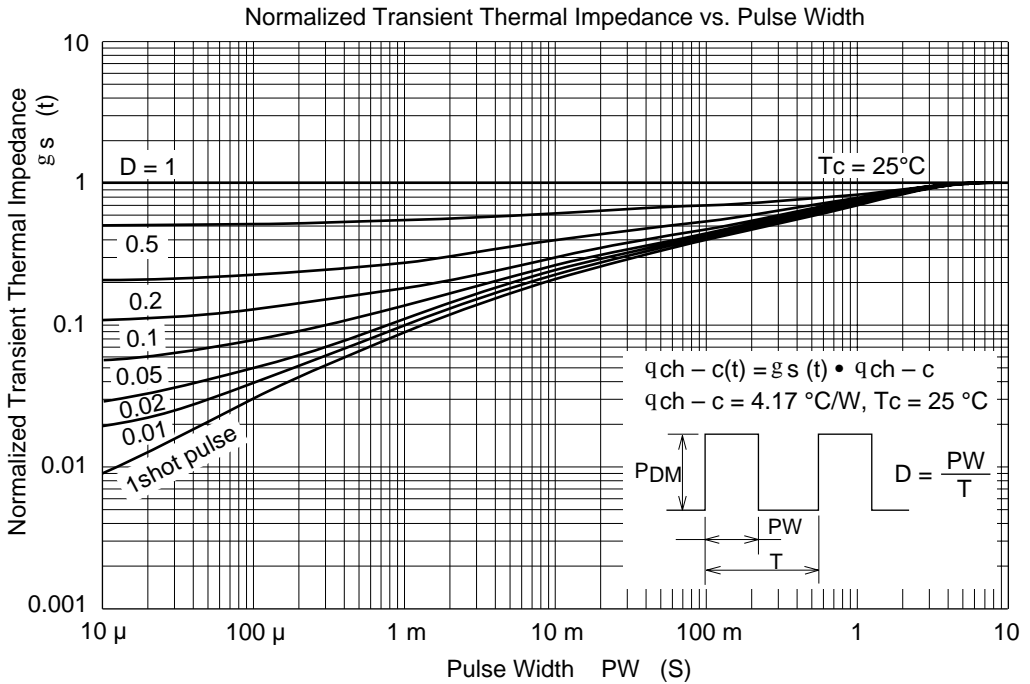
Note: 3. Pulse test

4. Include the time shift based on increasing of channel temperature when operate under over load condition.

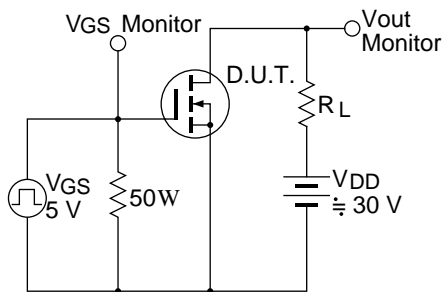
See characteristic curve of HAF2001.

## Main Characteristics

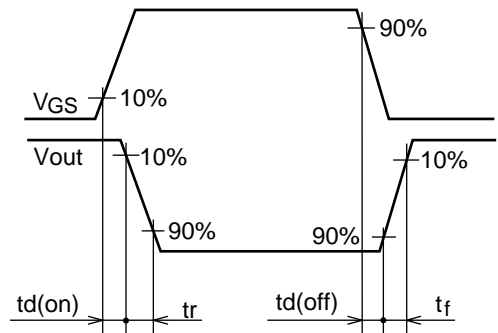




Switching Time Test Circuit

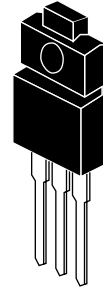
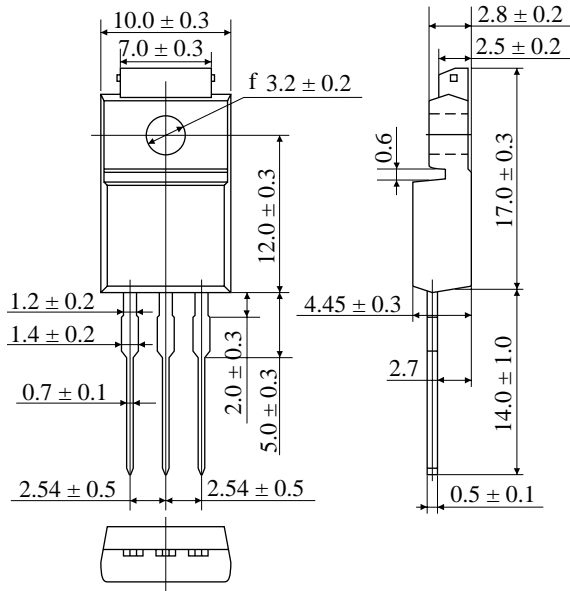


Waveform



## Package Dimensions

Unit: mm



|              |          |
|--------------|----------|
| Hitachi Code | TO-220FM |
| EIAJ         | SC-67    |
| JEDEC        | —        |

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